

74AC157 • 74ACT157 Quad 2-Input Multiplexer

General Description

The AC/ACT157 is a high-speed quad 2-input multiplexer. Four bits of data from two sources can be selected using the common Select and Enable inputs. The four outputs present the selected data in the true (noninverted) form. The AC/ACT157 can also be used as a function generator.

Features

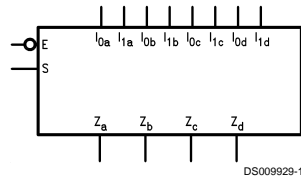
- I_{CC} and I_{OZ} reduced by 50%
- Outputs source/sink 24 mA
- ACT157 has TTL-compatible inputs

Ordering Code:

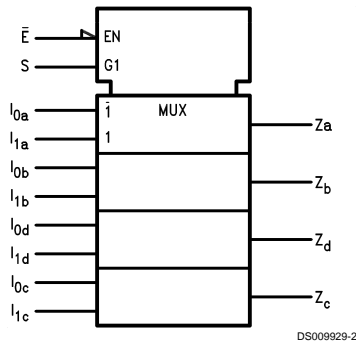
Order Number	Package Number	Package Description
74AC157SC	M16A	16-Lead Molded Small Outline Package
74AC157PC	N16E	16-Lead Molded Dual-In-Line Package
74AC157SJ	M16D	16-Lead (0.300" Wide) Molded Small Outline Package, EIAJ
74AC157MTC	MTC16	16 -Lead Molded Small Outline Package

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbol

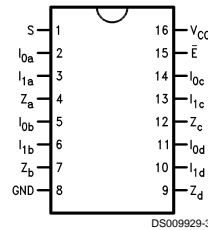


IEEE/IEC



Connection Diagram

Pin Assignment for DIP and SOIC



Pin Descriptions

Pin Names	Description
I_{0a} – I_{0d}	Source 0 Data Inputs
I_{1a} – I_{1d}	Source 1 Data Inputs
\bar{E}	Enable Input
S	Select Input
Z_a – Z_d	Outputs

Functional Description

The AC/ACT157 is a quad 2-input multiplexer. It selects four bits of data from two sources under the control of a common Select input (S). The Enable input (\bar{E}) is active-LOW. When \bar{E} is HIGH, all of the outputs (Z) are forced LOW regardless of all other inputs. The AC/ACT157 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equations for the outputs are shown below:

$$Z_a = \bar{E} \cdot (I_{1a} \cdot S + I_{0a} \cdot \bar{S})$$

$$Z_b = \bar{E} \cdot (I_{1b} \cdot S + I_{0b} \cdot \bar{S})$$

$$Z_c = \bar{E} \cdot (I_{1c} \cdot S + I_{0c} \cdot \bar{S})$$

$$Z_d = \bar{E} \cdot (I_{1d} \cdot S + I_{0d} \cdot \bar{S})$$

A common use of the AC/ACT157 is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select input. A less obvious use is as a function generator. The AC/ACT157 can generate any four of

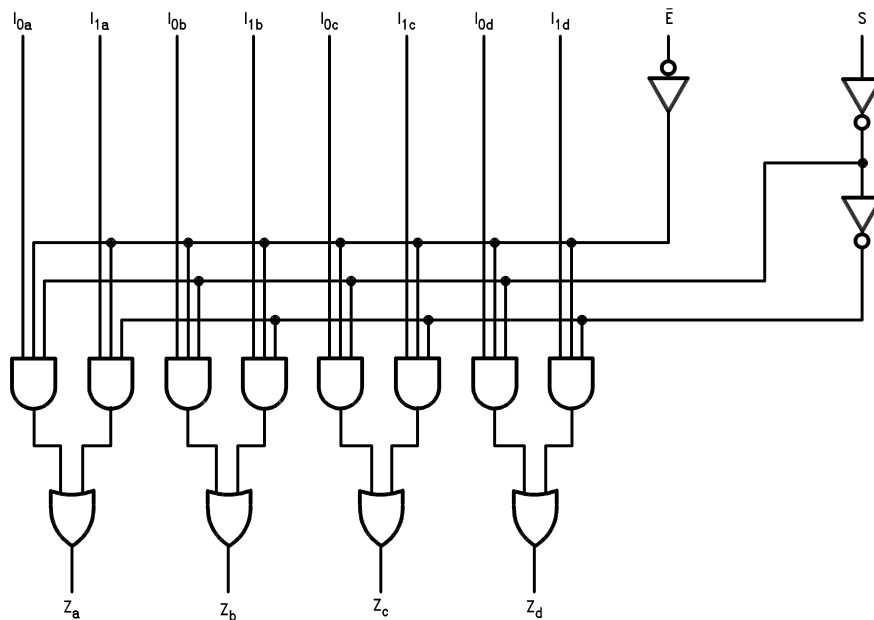
the sixteen different functions of two variables with one variable common. This is useful for implementing gating functions.

Truth Table

Inputs				Outputs
\bar{E}	S	I_0	I_1	Z
H	X	X	X	L
L	H	X	L	L
L	H	X	H	H
L	L	L	X	L
L	L	H	X	H

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

Logic Diagram



DS009929-5

Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings (Note 1)

Supply Voltage (V_{CC})	-0.5V to +7.0V
DC Input Diode Current (I_{IK})	
$V_I = -0.5V$	-20 mA
$V_I = V_{CC} + 0.5V$	+20 mA
DC Input Voltage (V_I)	-0.5V to $V_{CC} + 0.5V$
DC Output Diode Current (I_{OK})	
$V_O = -0.5V$	-20 mA
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage (V_O)	-0.5V to $V_{CC} + 0.5V$
DC Output Source or Sink Current (I_O)	±50 mA
DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})	±50 mA
Storage Temperature (T_{STG})	-65°C to +150°C
Junction Temperature (T_J)	
PDIP	140°C

Recommended Operating Conditions

Supply Voltage (V_{CC})	
AC	2.0V to 6.0V
ACT	4.5V to 5.5V
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Temperature (T_A)	-40°C to +85°C
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
AC Devices	
V_{IN} from 30% to 70% of V_{CC}	
V_{CC} @ 3.3V, 4.5V, 5.5V	125 mV/ns
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
ACT Devices	
V_{IN} from 0.8V to 2.0V	
V_{CC} @ 4.5V, 5.5V	125 mV/ns

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics for AC Family Devices

Symbol	Parameter	V_{CC} (V)	$T_A = +25^\circ\text{C}$		$T_A = -40^\circ\text{C to } +85^\circ\text{C}$	Units	Conditions	
			Typ	Guaranteed Limits				
V_{IH}	Minimum High Level Input Voltage	3.0	1.5	2.1	2.1	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		4.5	2.25	3.15	3.15			
		5.5	2.75	3.85	3.85			
V_{IL}	Maximum Low Level Input Voltage	3.0	1.5	0.9	0.9	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$	
		4.5	2.25	1.35	1.35			
		5.5	2.75	1.65	1.65			
V_{OH}	Minimum High Level Output Voltage	3.0	2.99	2.9	2.9	V	$I_{OUT} = -50 \mu A$	
		4.5	4.49	4.4	4.4			
		5.5	5.49	5.4	5.4			
			3.0		2.56	2.46	V	$V_{IN} = V_{IL}$ or V_{IH} $I_{OH} = -12 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ (Note 2)
			4.5		3.86	3.76		
			5.5		4.86	4.76		
V_{OL}	Maximum Low Level Output Voltage	3.0	0.002	0.1	0.1	V	$I_{OUT} = 50 \mu A$	
		4.5	0.001	0.1	0.1			
		5.5	0.001	0.1	0.1			
			3.0		0.36	0.44	V	$V_{IN} = V_{IL}$ or V_{IH} $I_{OL} = 12 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ (Note 2)
			4.5		0.36	0.44		
			5.5		0.36	0.44		
I_{IN} (Note 4)	Maximum Input Leakage Current	5.5		±0.1	±1.0	μA	$V_I = V_{CC}, \text{ GND}$	
I_{OLD}	Minimum Dynamic	5.5			75	mA	$V_{OLD} = 1.65V \text{ Max}$	
I_{OHD}	Output Current (Note 3)	5.5			-75	mA	$V_{OHD} = 3.85V \text{ Min}$	
I_{CC} (Note 4)	Maximum Quiescent Supply Current	5.5		4.0	40.0	μA	$V_{IN} = V_{CC}$ or GND	

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: Maximum test duration 2.0 ms, one output loaded at a time.

Note 4: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

DC Characteristics for ACT Family Devices

Symbol	Parameter	V _{CC} (V)	T _A = +25°C		T _A = -40°C to +85°C	Units	Conditions
			Typ	Guaranteed Limits			
V _{IH}	Minimum High Level Input Voltage	4.5	1.5	2.0	2.0	V	V _{OUT} = 0.1V or V _{CC} - 0.1V
		5.5	1.5	2.0	2.0		
V _{IL}	Maximum Low Level Input Voltage	4.5	1.5	0.8	0.8	V	V _{OUT} = 0.1V or V _{CC} - 0.1V
		5.5	1.5	0.8	0.8		
V _{OH}	Minimum High Level Output Voltage	4.5	4.49	4.4	4.4	V	I _{OUT} = -50 μA
		5.5	5.49	5.4	5.4		
		4.5		3.86	3.76	V	V _{IN} = V _{IL} or V _{IH} I _{OH} = -24 mA I _{OH} = -24 mA (Note 5)
5.5		4.86	4.76				
V _{OL}	Maximum Low Level Output Voltage	4.5	0.001	0.1	0.1	V	I _{OUT} = 50 μA
		5.5	0.001	0.1	0.1		
		4.5		0.36	0.44	V	V _{IN} = V _{IL} or V _{IH} I _{OL} = 24 mA I _{OL} = 24 mA (Note 5)
5.5		0.36	0.44				
I _{IN}	Maximum Input Leakage Current	5.5		±0.1	±1.0	μA	V _I = V _{CC} , GND
I _{CC}	Maximum I _{CC} /Input	5.5	0.6		1.5	mA	V _I = V _{CC} - 2.1V
I _{OLD}	Minimum Dynamic Output Current (Note 6)	5.5			75	mA	V _{OLD} = 1.65V Max
I _{OHD}	Maximum Dynamic Output Current (Note 6)	5.5			-75	mA	V _{OHD} = 3.85V Min
I _{CC}	Maximum Quiescent Supply Current	5.5		4.0	40.0	μA	V _{IN} = V _{CC} or GND

Note 5: All outputs loaded; thresholds on input associated with output under test.

Note 6: Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics for AC

Symbol	Parameter	V _{CC} (V) (Note 7)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
			t _{PLH}	Propagation Delay S to Z _n	3.3	1.5	7.0	
5.0	1.5	5.5			9.0	1.5	10.0	
t _{PHL}	Propagation Delay S to Z _n	3.3	1.5	6.5	11.0	1.5	12.0	ns
		5.0	1.5	5.0	8.5	1.0	9.5	
t _{PLH}	Propagation Delay Ē to Z _n	3.3	1.5	7.0	11.5	1.5	13.0	ns
		5.0	1.5	5.5	9.0	1.5	10.0	
t _{PHL}	Propagation Delay Ē to Z _n	3.3	1.5	6.5	11.0	1.5	12.0	ns
		5.0	1.5	5.5	9.0	1.0	9.5	
t _{PLH}	Propagation Delay I _n to Z _n	3.3	1.5	5.0	8.5	1.0	9.0	ns
		5.0	1.5	4.0	6.5	1.0	7.0	
t _{PHL}	Propagation Delay I _n to Z _n	3.3	1.5	5.0	8.0	1.0	9.0	ns
		5.0	1.5	4.0	6.5	1.0	7.0	

Note 7: Voltage Range 3.3 is 3.3V ±0.3V

Voltage Range 5.0 is 5.0V ±0.5V

AC Electrical Characteristics for ACT

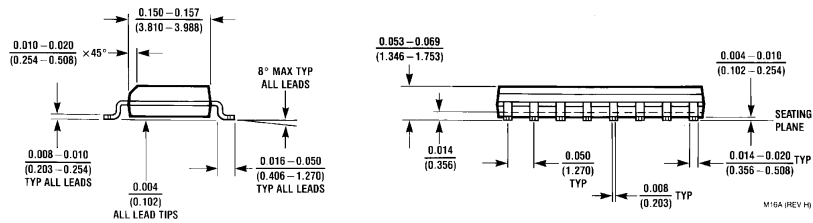
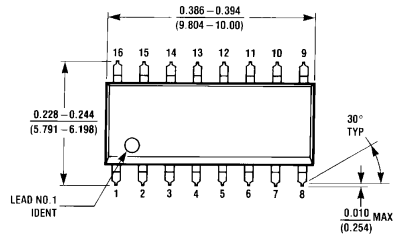
Symbol	Parameter	V _{CC} (V) (Note 8)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
t _{PLH}	Propagation Delay S to Z _n	5.0	2.0	5.5	9.0	1.5	10.0	ns
t _{PHL}	Propagation Delay S to Z _n	5.0	2.0	5.5	9.5	2.0	10.5	ns
t _{PLH}	Propagation Delay Ē to Z _n	5.0	1.5	6.0	10.0	1.5	11.5	ns
t _{PHL}	Propagation Delay Ē to Z _n	5.0	1.5	5.0	8.5	1.0	9.0	ns
t _{PLH}	Propagation Delay I _n to Z _n	5.0	1.5	4.0	7.0	1.0	8.5	ns
t _{PHL}	Propagation Delay I _n to Z _n	5.0	1.5	4.5	7.5	1.0	8.5	ns

Note 8: Voltage Range 5.0 is 5.0V ±0.5V

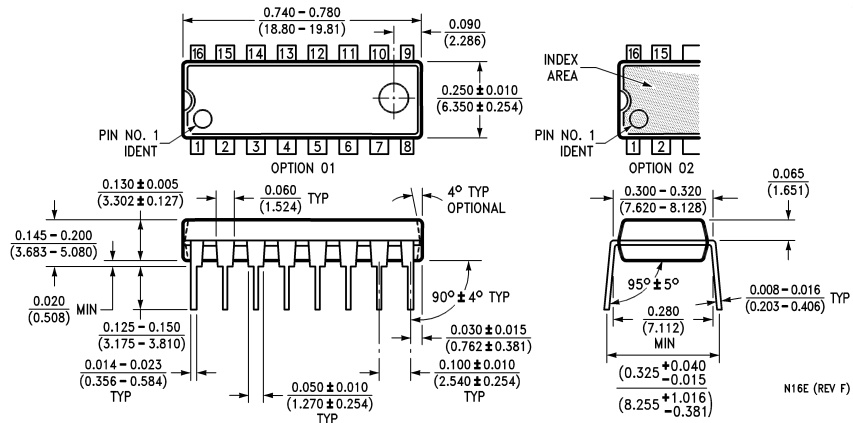
Capacitance

Symbol	Parameter	Typ	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN
C _{PD}	Power Dissipation Capacitance	50.0	pF	V _{CC} = 5.0V

Physical Dimensions inches (millimeters) unless otherwise noted

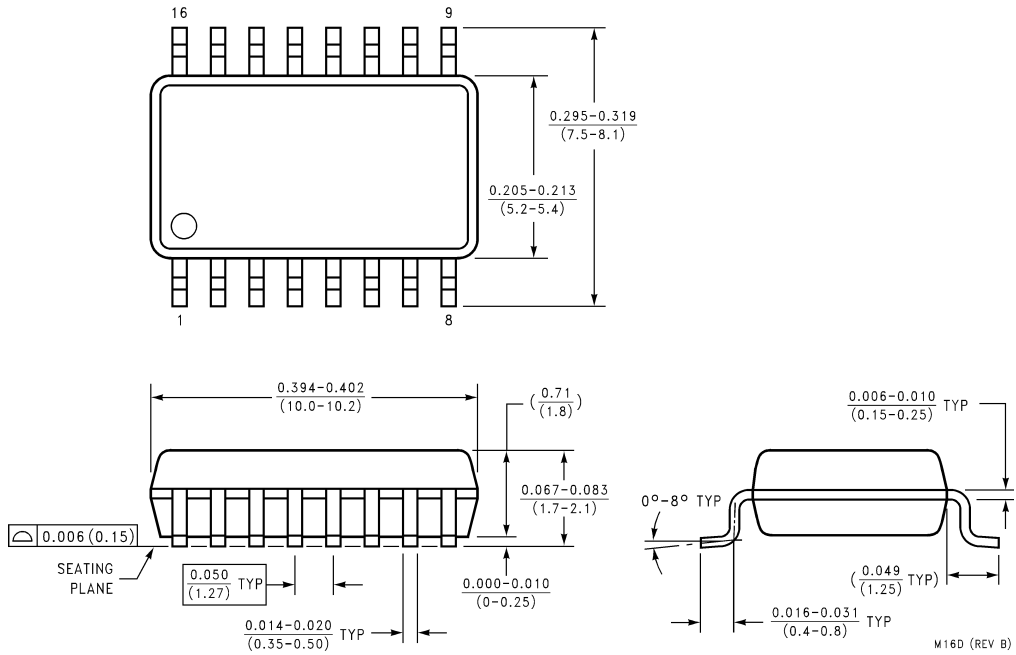


**16-Lead Molded Small Outline Package
Package Number M16A**



**16-Lead Molded Dual-In-Line Package
Package Number N16E**

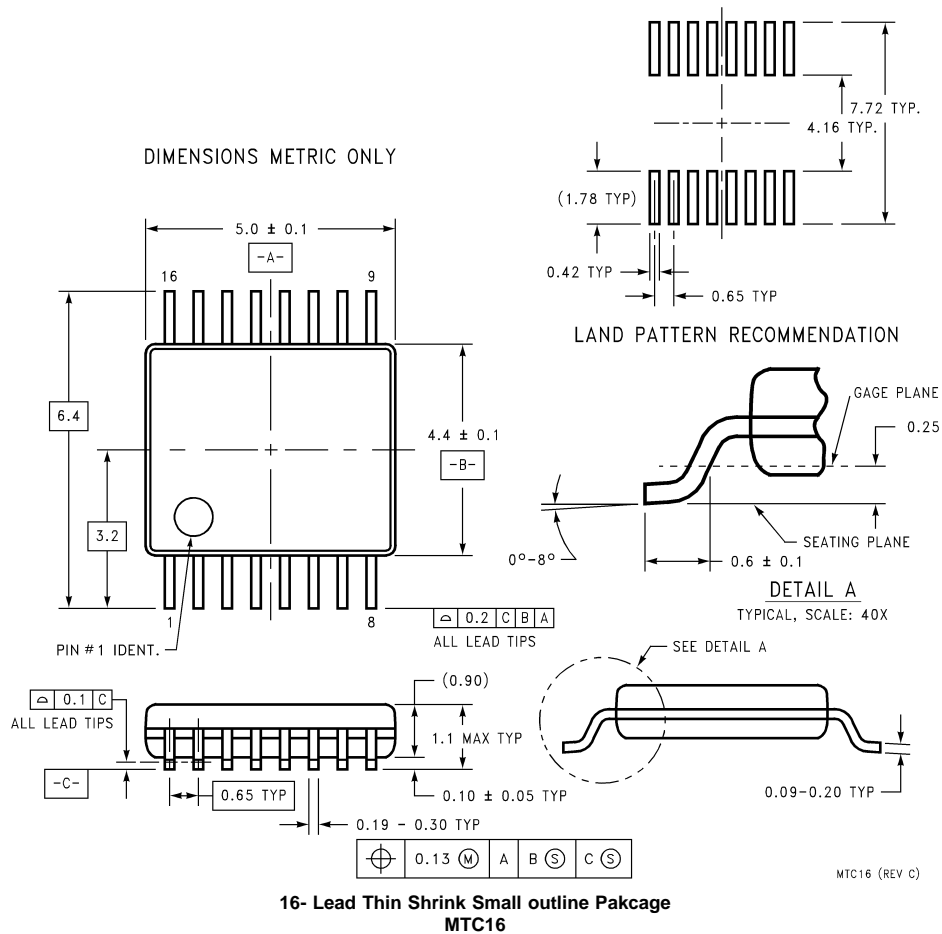
Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**16-Lead (0.300" Wide) Molded Small Outline Package, EIAJ
Package Number M16D**

M16D (REV B)

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



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